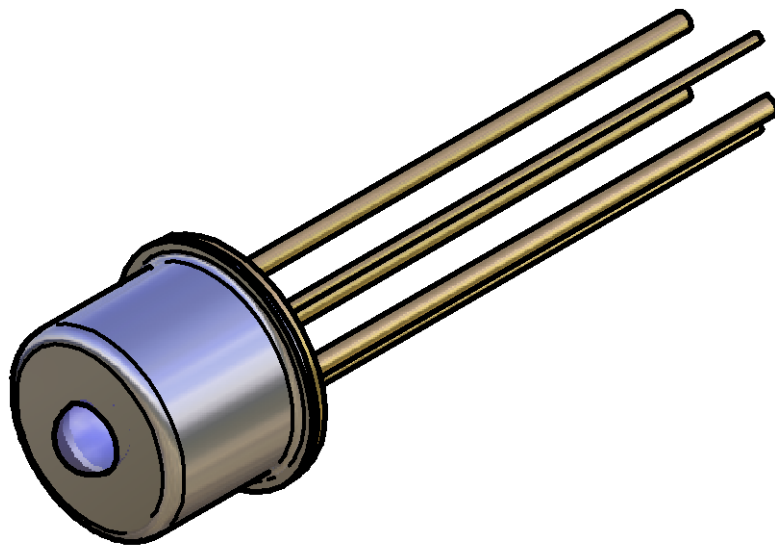


**Wooriro Photo Diode**

**WOORIRO 3G APD TIA TO  
SPECIFICATION**



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### General Description

The reliable avalanche photodiodes with TIA are hermetically sealed with AR coated ball lens caps. WOS-E-1302-33 has sensitive area of 55um diameter and it will be easily coupled with a single mode fiber.

### Features

- InGaAs APD chip for 3Gbps
- High gain 3.6kΩ transimpedance pre-amplifier for 3Gbps
- Operation at 1100nm and 1650nm
- Differential data outputs
- High sensitivity: typ. -34dBm@3.125Gbps

### Applications

- Digital fiber optic receiver in short, medium and long haul optical telecommunications transmission systems or in high speed data networks
- Metro Access Rings
- Point-to-Point Networking
- 1xFiber Channel
- Gigabit Ethernet

### Absolute Maximum Ratings

Parameter	Symbol	Rating	Unit
TIA supply voltage	V <sub>CC</sub>	-0.7 to +5.0	V
APD supply voltage	V <sub>APD</sub>	0 to V <sub>BR</sub>	V
APD reverse current	I <sub>APD</sub>	3.0	mA
Operating case temperature range	T <sub>C</sub>	-40 to +85	°C
Storage temperature range	T <sub>STG</sub>	-40 to +85	°C

Table 1. Absolute Maximum Ratings

### Electro-Optical Characteristics

Inspection sheet shall be an appended to products when they are delivered. It shall contain the following items. (\*) Test report shall be submitted in papers and in electronic media.

#### Optical Characteristics(Tc=25°C)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Optical wavelength range	$\lambda$	-	1100		1650	nm
Sensitivity	$P_S$	3.125Gbps NRZ, PRBS= $2^{23}-1$ , BER= $1 \times 10^{-10}$ , $M_{opt}$ ER=12.7dB, $\lambda=1550$ nm		-34	-32	dBm
Maximum overload	$P_{MAX}$	3.125Gbps NRZ, PRBS= $2^{23}-1$ , BER= $1 \times 10^{-10}$ , $M_{opt}$ ER=12.7dB, $\lambda=1550$ nm	0			dBm
Responsivity	R	$\lambda=1550$ , M=1	0.8			A/W

Table 2. Optical Characteristics

#### Electrical Characteristics(Tc=25°C)

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Power supply voltage	$V_{CC}$	-	3.0	3.3	3.6	V
Power supply current	$I_{CC}$	-	33	44	59	mA
Breakdown voltage	$V_{BR}$	Dark current, $I_d=10\mu A$	35	45	55	V
Transimpedance	$Z_T$	Differential(50Ω on each output), f=100MHz	2.3	3.6	4.7	KΩ
O/E bandwidth	$f_{ch}$	-3dB, M=10, Pin=-20dBm	1.65	2.05	2.5	GHz
Low cut-off frequency	$f_{cl}$	-		3	5	KHz
Maximum output voltage	$V_{out}$	Differential			340	mV <sub>p-p</sub>
Output impedance	$Z_O$	Single-ended		50		Ω
Temperature coefficient of $V_{BR}$	$\delta$	-	80	100	120	mV/°C

Table 3. Electro Characteristics

**Structure**

**Dimensional Parameter**

(unit : mm)

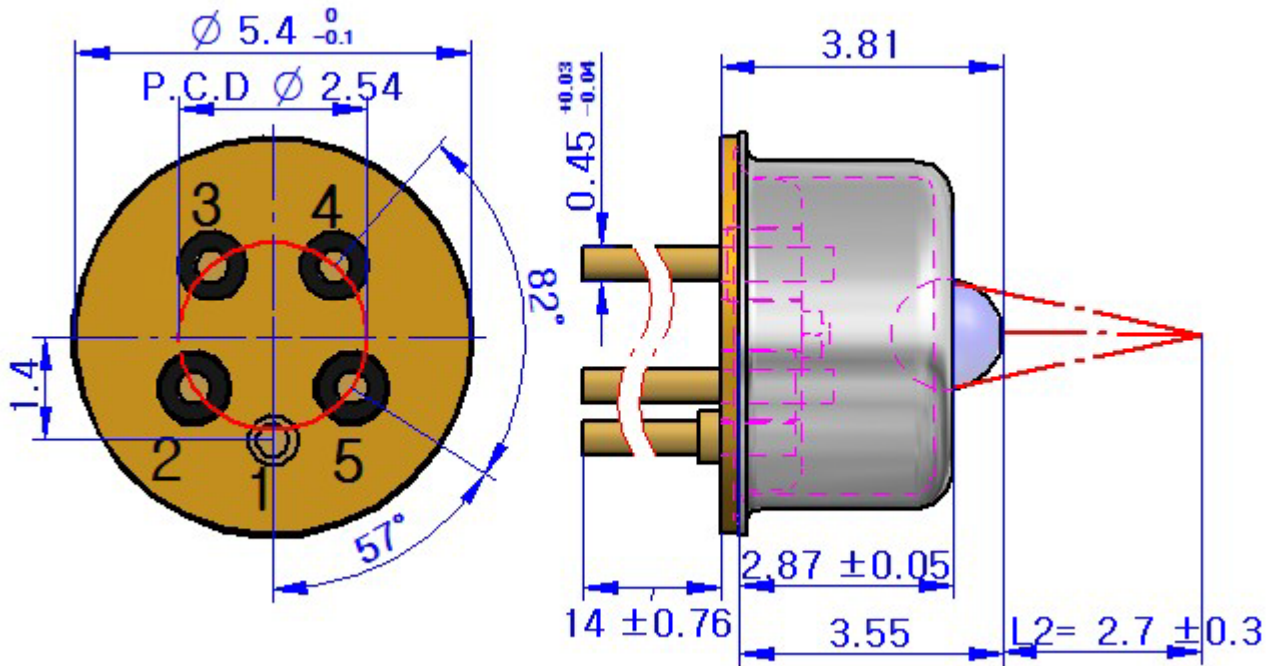


Figure 1. Mechanical Dimension

**Pin Configuration**

No.	Symbol	I/O	Description
1	GND	I/O	Signal ground
2	Data P	O	Positive data output
3	V <sub>CC</sub>	I	Supply voltage
4	V <sub>APD</sub>	I	APD bias voltage
5	Data N	O	Negative data output

Table 4. PIN Configuration

## Other Requirements

### Precautions for use

- 1) This device is susceptible to damage as a result of ESD(electrostatic discharge). Use of ground straps, anti static mats, and other standard ESD protective equipment is recommended when handling or testing an InGaAs PIN/APD or any other junction photodiode. Soldering temperature of the leads should not exceed 350°C for more than 10 seconds.
- 2) During the optical alignment before laser welding or epoxy bonding, the APD chip would respond to input optical signal under the condition of high applied voltage lager than 60% of VB. Thus, 80% of VB is recommended for optical alignment

## ORDERING INFORMATION

